## Notice of References Cited

-	Application/Control No. 10/083,188	Applicant(s)/Patent Uncer Reexamination TOBA, AKIO		
	Examiner	Art Unit		
,	Yahveh Comas	2834	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,225,725	07-1993	Shiraki et al.	310/12
*	В	US-4,786,832	11-1988	Nakagawa et al.	310/12
*	С	US-4,370,577	01-1983	Wakabayashi et al.	310/12
*	D	US-4,661,730	04-1987	Maruyama et al.	310/12
*	Ш	US-4,594,520	06-1986	Miwa et al.	310/12
*	F	US-4,860,183	08-1989	Maeda et al.	363/12
*	G	US-4,945,268	07-1990	Nihei et al.	310/12
*	Ι	US-4,563,602	01-1986	Nagasaka, Nagahiko	310/12
*	_	US-4,504,750	03-1985	Onodera et al.	310/12
*	7	US-			
*	K	US-			
*	٦	US-			
*	Σ	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 62107667 A	05-1987	Japan	OTA, HIROBUMI	H02K 41/03
	0	JP 02246762 A	10-1990	Japan	KANAZAWA et al.	H02K 41/03
	Р	JP 62104470 A	05-1987	Japan	INASUMI, HIROKUNI	H02K 41/03
	Q	JP 2000092809 A	03-2000	Japan	MORIKI, YUICHI	H02K 33/18
	R	JP 01174262 A	07-1989	Japan	NIHEI et al.	H02K 41/03
	S	JP 62166763 A	07-1987	Japan	MAEDA, TETSUO	H02 < 41/03
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	٧				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.